Application/Control	No
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Examiner

Jason M. Han

	Applicant(s)/Patent under Reexamination	
_	HAYASHI ET AI	
	Art Unit	
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SEARCHED				
Class	Subclass	Date	Examiner	
362	460	12/12/2005	ЈМН	
362	464-467	12/12/2005	JMH	
362	485	3/20/2006	ЈМН	
362	523	12/12/2005	ЈМН	
362	525	12/12/2005	ЈМН	
73	627-628	3/20/2006	ЈМН	
315	77, 82	3/20/2006	ЈМН	
340	306	3/20/2006	JMH	
340	440	3/20/2006	ЈМН	
702	104	3/20/2006	JMH	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	-PGPUB) - ence Printout	3/20/2006	JMH

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWEMT) - See Printout	3/20/2006	JMH
P.E. Thomas Mullen for Class 340	3/20/2006	JMH
John Fitzgerald for Class 73	3/20/2006	ЈМН
P.E. Wilson Lee for Class 315	3/20/2006	ЈМН
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